

Table 6. Z85C30 Read/Write Timing (continued)

No	Symbol	Parameter	8.5 MHz		10 MHz		16 MHz	
			Min	Max	Min	Max	Min	Max
48	TwRES	$\overline{\text{WR}}$ and $\overline{\text{RD}}$ Low for Reset	145		100		75	
49a	Trc ^e	Valid Access Recovery Time	3.5TcPc	3.5TcPc	3.5TcPc			
49b	Trci ^f	$\overline{\text{RD}}$ or $\overline{\text{WR}}$ Fall to PC Fall Setup Time	0		0		0	

Notes:

1. Parameter does not apply to Interrupt Acknowledge transactions.
2. Open-drain output, measured with open-drain test load.
3. Parameter applies to enhanced request mode only ($\text{WR7}'\text{D4} = 1$).
4. Parameter is system-dependent. For any SCC in the daisy chain, TdIAi(RD) must be greater than the sum of TdPC(IEO) for the highest priority device in the daisy chain. TsiEI(RDA) for the SCC and TdIEI(IEO) for each device separating them in the daisy chain.
5. Parameter applies only between transactions involving the Z85C30 SL1480, if $\text{WR}/\overline{\text{RD}}$ falling edge is synchronized to PCLK falling edge, then $\text{TrC} = 3\text{TcPc}$.
6. This specification is only applicable when Valid Access Recovery Time is less than 35 PCLK.

Figure 33 shows a general timing diagram for the Z85C30 device.

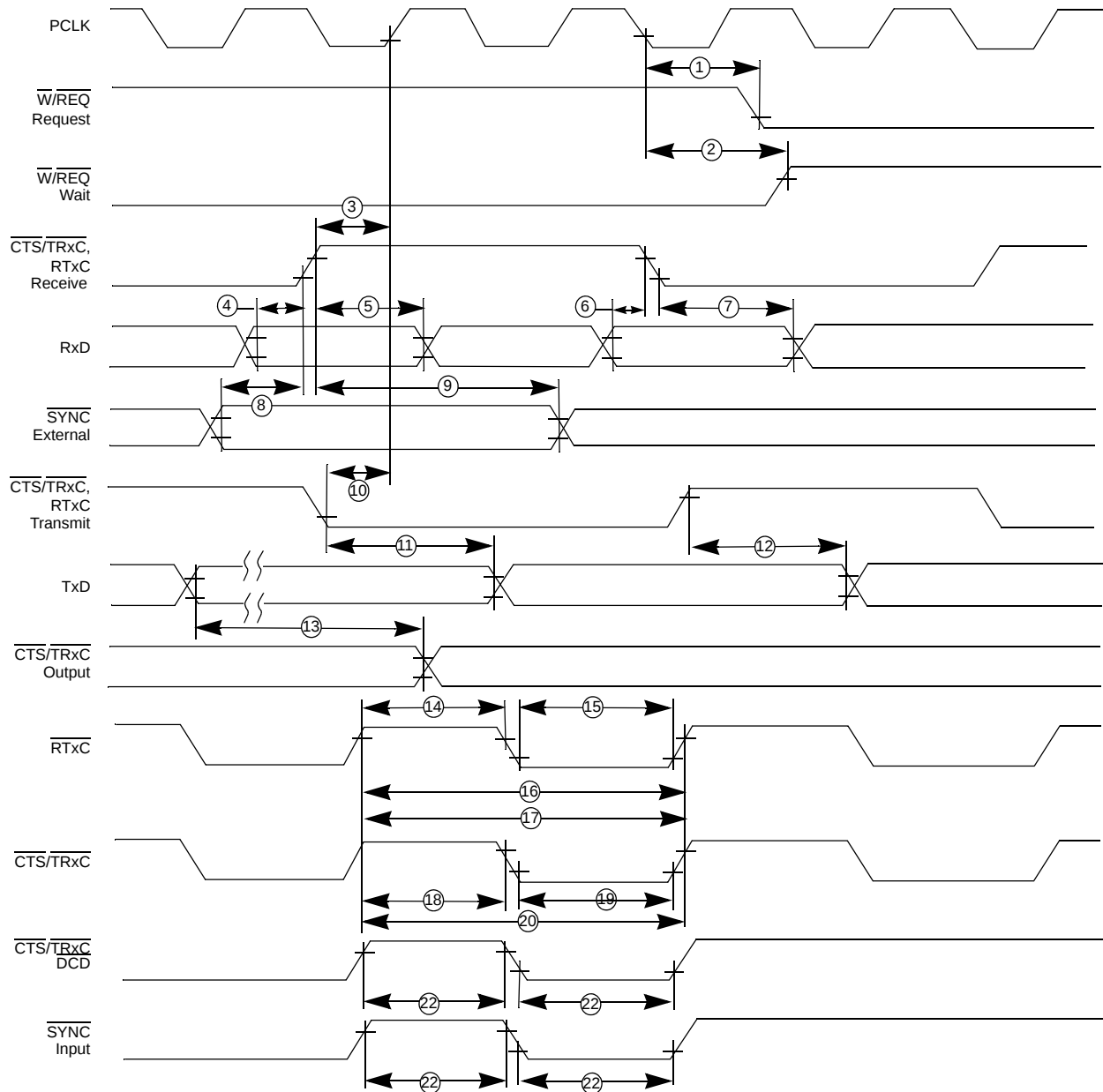


Figure 33. Z85C30 General Timing Diagram

Z85C30 General Timing Table lists the general timing characteristics for the Z85C30 device.

Table 7. Z85C30 General Timing Table

No	Symbol	Parameter	8.5MHz		10MHz		16MHz	
			Min	Max	Min	Max	Min	Max
1	TdPC(REQ)	PCLK to W/REQ Valid		250		150		80
2	TdPC(W)	PCLK to Wait Inactive		350		250		180
3	TsRXC(PC)	RxC to PCLK Setup Time ^{1,2}	N/A		N/A		N/A	
4	TsRXD(RxCr)	RxD to RxC Setup Time ¹		0		0		0
5	ThRXD(RxCr)	RxD to /RXC Hold Time ¹	150		125		50	
6	TsRXD(RXCf)	RxD to /RXC Setup Time ^{1,3}	0		0		0	
7	ThRXD(RXCf)	RxD to /RXC Hold Time ^{1,3}	150	1	25		50	
8	TsSY(RXC)	SYNC to RxC Setup Time ¹	-200		-150		-100	
9	ThSY(RXC)	SYNC to RxC Hold Time ¹	5TcPc		5TcPc		5TcPc	
10	TsTXC(PC)	TxC to PCLK Setup Time ^{4,5}	N/A		N/A		N/A	
11	TdTXCf(TXD)	TxC to Tx D Delay ⁴		200		150		80
12	TdTxCr(TXD)	TxC to Tx D Delay ^{3,4}		200		150		80
13	TdTXD(TRX)	TxD to TRxC Delay		200		140		80
14a	TwRTXh	RTxC High Width ⁶	150		120		80	
14b	TwRTXh(E)	RTxC High Width ⁷	50		40		15.6	
15a	TwRTXI	TRxC Low Width ⁶	150		120		80	
15b	TwRTXI(E)	RTxC Low Width ⁷	50		40		15.6	
16a	TcRTX	RTxC Cycle Time ^{6,8}	488		400		244	
16b	TcRTX(E)	RTxC Cycle Time ⁷	125		100		31.25	
17	TcRTXX	Crystal Osc. Period ⁹	125	1000	100	1000	62	1000

Notes:

1. RxC is $\overline{\text{RTxC}}$ or $\overline{\text{TRxC}}$, whichever is supplying the receive clock.
2. Synchronization of RxC to PCLK is eliminated in divide by four operation.
3. Parameter applies only to FM encoding/decoding.
4. TxC is $\overline{\text{TRxC}}$ or $\overline{\text{RTxC}}$, whichever is supplying the transmit clock.
5. External PCLK to RTxC or TxC synchronization requirement eliminated for PCLK divide-by-four operation. $\overline{\text{TRxC}}$ and $\overline{\text{RTxC}}$ rise and fall times are identical to PCLK. Reference timing specs TfPC and TrPC. Tx and Rx input clock slew rates should be kept to a maximum of 30 nsec. All parameters related to input CLK edges must be referenced at the point at which the transition begins or ends, whichever is worst case.
6. Parameter applies only for transmitter and receiver; DPLL and Baud Rate Generator timing requirements are identical to case PCLK requirements.
7. Enhanced Feature — $\overline{\text{RTxC}}$ used as input to internal DPLL only.
8. The maximum receive or transmit data rate is 1/4 PCLK.
9. Both $\overline{\text{RTxC}}$ and $\overline{\text{SYNC}}$ have 30 pF capacitors to ground connections.

Table 7. Z85C30 General Timing Table (continued)

No	Symbol	Parameter	8.5MHz		10MHz		16MHz	
			Min	Max	Min	Max	Min	Max
18	TwTRXh	TRxC High Width ⁶	150		120		180	
19	TwTRXI	TRxC Low Width ⁶	150		120		80	
20	TcTRX	TRxC Cycle Time ^{6,8}	488		400		244	
21	TwEXT	DCD or CTS Pulse Width	200		120		70	
22	TwSY	SYNC Pulse Width	200		120		70	

Notes:

1. RxC is $\overline{\text{RTxC}}$ or $\overline{\text{TRxC}}$, whichever is supplying the receive clock.
2. Synchronization of RxC to PCLK is eliminated in divide by four operation.
3. Parameter applies only to FM encoding/decoding.
4. TxC is $\overline{\text{TRxC}}$ or $\overline{\text{RTxC}}$, whichever is supplying the transmit clock.
5. External PCLK to RTxC or TxC synchronization requirement eliminated for PCLK divide-by-four operation. $\overline{\text{TRxC}}$ and $\overline{\text{RTxC}}$ rise and fall times are identical to PCLK. Reference timing specs TfPC and TrPC. Tx and Rx input clock slew rates should be kept to a maximum of 30 nsec. All parameters related to input CLK edges must be referenced at the point at which the transition begins or ends, whichever is worst case.
6. Parameter applies only for transmitter and receiver; DPLL and Baud Rate Generator timing requirements are identical to case PCLK requirements.
7. Enhanced Feature — $\overline{\text{RTxC}}$ used as input to internal DPLL only.
8. The maximum receive or transmit data rate is 1/4 PCLK.
9. Both $\overline{\text{RTxC}}$ and $\overline{\text{SYNC}}$ have 30 pF capacitors to ground connections.

Figure 34 shows the system timing for the Z85C30 device.

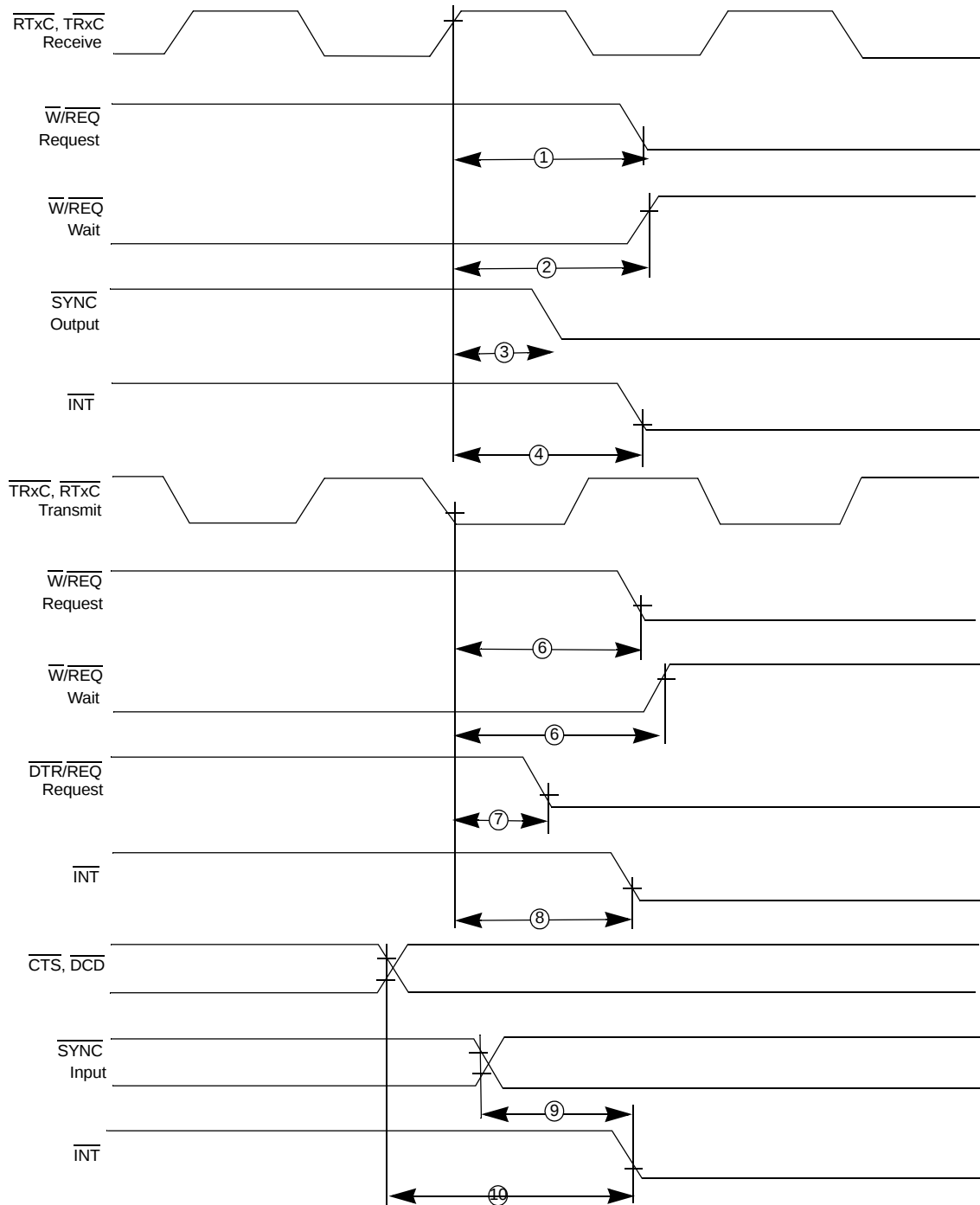


Figure 34. Z85C30 System Timing Diagram

Z85C30 System Timing Table lists the system timing characteristics for the Z85C30 device.

Table 8. Z85C30 System Timing Table

No	Symbol	Parameter	8.5MHz		10MHz		16MHz	
			Min	Max	Min	Max	Min	Max
1	TdRXC(REQ)	RxC High to W/REQ Valid ^{1,2}	8	12	8	12	8	12
2	TdRXC(W)	RxC High to Wait Inactive ^{1,2,3}	8	14	8	14	8	14
3	TdRdXC(SY)	RxC High to SYNC Valid ^{1,2}	4	7	4	7	4	70
4	TsRXC(INT)	RxC High to INT Valid ^{1,2,3}	10	16	10	16	10	16
5	TdTXC(REQ)	TxC Low to W/REQ Valid ^{2,4}	5	8	5	8	5	8
6	TdTXC(W)	TxC Low to Wait Inactive ^{2,3,4}	5	11	5	11	5	11
7	TdTXC(DRQ)	TxC Low to DTR/REQ Valid ^{3,4}	4	7	4	7	4	7
8	TdTXC(INT)	TxC Low to INT Valid ^{2,3,4}	6	10	6	10	6	10
9a	TdSY(INT)	SYNC to INT Valid ^{2,3}	2	6	2	6	2	6
9b	TdSY(INT)	SYNC to INT Valid ^{2,3,5}	2	3	2	3	2	3
10	TdEXT(INT)	DCD or CTS to INT Valid ^{2,3}	2	6	2	6	2	6

Notes:

1. RxC is RTxC or TRxC, whichever is supplying the receive clock.
2. Units equal to TcPc.
3. Open-drain output, measured with open-drain test load.
4. TxC is TRxC or RTxC whichever is supplying the transmit clock.
5. Units equal to AS.

Z85C30 Read/Write Timing provides the read/write timing characteristics for the Z85C30 device.

Table 9. Z85C30 Read/Write Timing

No	Symbol	Parameter	8.5MHz		10MHz		16MHz	
			Min	Max	Min	Max	Min	Max
1	TwPCI	PCLK Low Width	45	2000	40	2000	26	2000
2	TwPCh	PCLK High Width	45	2000	40	2000	26	2000
3	TfPC	PCLK Fall Time		10		10		5
4	TrPC	PCLK Rise Time		10		10		5
5	TcPC	PCLK Cycle Time	118	4000	100	4000	61	4000
6	TsA(WR)	Address to WR Fail Setup Time	66		50		35	
7	ThA(WR)	Address to WR Rise Hold Time	0		0		0	

Table 9. Z85C30 Read/Write Timing (continued)

No	Symbol	Parameter	8.5MHz		10MHz		16MHz	
			Min	Max	Min	Max	Min	Max
8	TsA(RD)	Address to $\overline{\text{RD}}$ Fall Setup Time	66		50		35	
9	ThA(RD)	Address to $\overline{\text{RD}}$ Rise Hold Time	0		0		0	
10	TsiA(PC)	$\overline{\text{INTACK}}$ to PCLK Rise Setup Time	20		20		15	

Figures 35 through 37 show the read/write timing, interrupt acknowledge timing and reset timing, respectively, for the Z80C30 device.

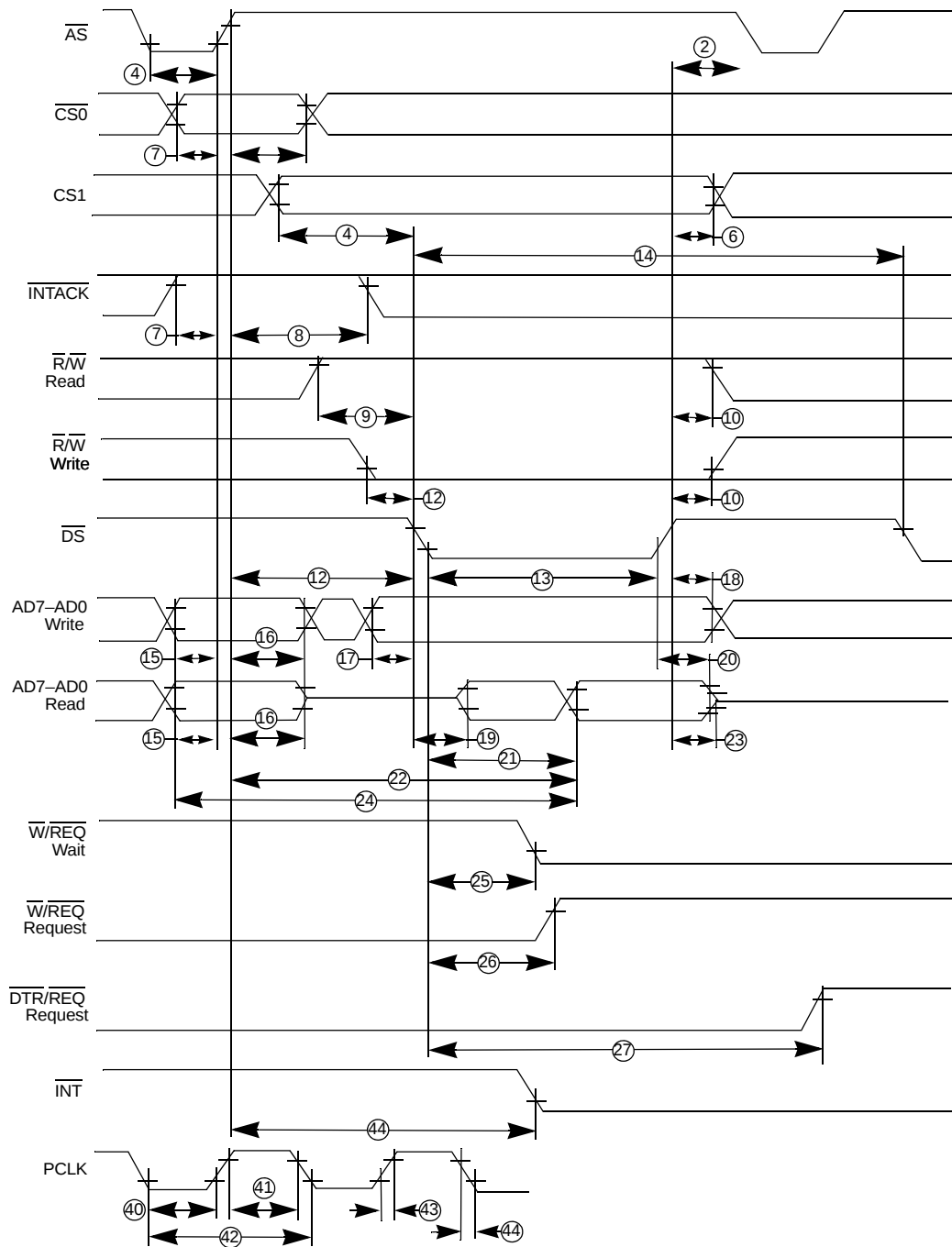


Figure 35. Z80C30 Read/Write Timing Diagram

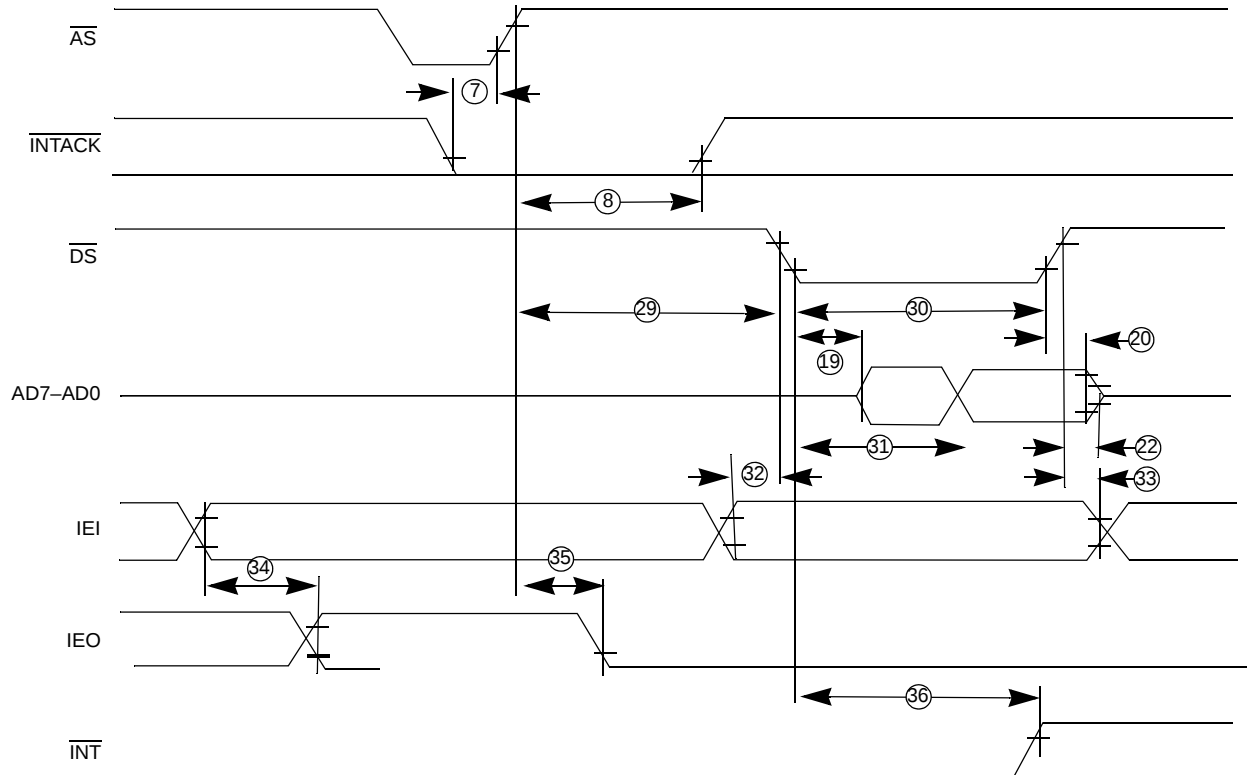


Figure 36. Z80C30 Interrupt Acknowledge Timing Diagram

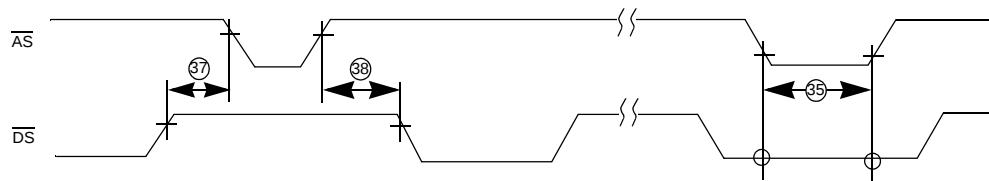


Figure 37. Z80C30 Reset Timing Diagram

Z80C30 Read/Write Timing¹ provides the read/write timing characteristics for the Z80C30 device.

Table 10. Z80C30 Read/Write Timing¹

No	Symbol	Parameter	8 MHz		10 MHz	
			Min	Max	Min	Max
1	TwAS	AS Low Width	35		30	
2	TdDS(AS)	DS Rise to AS Fall Delay ²	15		10	
3	TsCSO(AS)	CS0 to AS Rise Setup Time ²	0		0	
4	ThCSO(AS)	CS0 to AS Rise Hold Time ²	30		20	
5	TsCS1(DS)	CS1 to DS Fall Setup Time ²	65		50	
6	ThCS1(DS)	CS1 to DS Rise Hold Time ²	30		20	
7	TsiA(AS)	INTACK to AS Rise Setup Time	10		10	
8	ThIA(AS)	INTACK to AS Rise Hold Time	150		125	
9	TsRWR(DS)	R/W (Read) to DS Fall Setup Time	65		50	
10	ThRW(DS)	R/W to DS Rise Hold Time	0		0	
11	TsRWW(DS)	R/W (Write) to DS Fall Setup Time	0		0	
12	TdAS(DS)	AS Rise to DS Fall Delay	30		20	
13	TwDSI	DS Low Width	150		125	
14	TrC	Valid Access Recovery Time ³	4TcPC		4TcPC	
15	TsA(AS)	Address to AS Rise Setup Time ²	10		10	
16	ThA(AS)	Address to AS Rise Hold Time ²	25		20	
17	TsDW(DS)	Write Data to DS Fall Setup Time	15		10	
18	ThDW(DS)	Write Data to DS Rise Hold Time	0		0	
19	TdDS(DA)	DS Fall to Data Active Delay	0		0	
20	TdDSr(DR)	DS Rise to Read Data Not Valid Delay	0		0	
21	TdDSf(DR)	DS Fall to Read Data Valid Delay		140		120

Notes:

- Units in nanoseconds (ns) unless otherwise noted.
- Parameter does not apply to Interrupt Acknowledge transactions.
- Parameter applies only between transactions involving the SCC.
- Float delay is defined as the time required for a ± 0.5 V change in the output with a maximum DC load and a minimum AC load.
- Open-drain output, measured with open-drain test load.
- Parameter is system dependent. For any Z-SCC in the daisy chain. TdAS(DSA) must be greater than the sum of TdAS(IEO) for the highest priority device in the daisy chain TsiEI(DSA) for the Z-SCC, and TdIEIf(IEO) for each device separating them in the daisy chain.
- Parameter applies only to a Z-SCC pulling INT Low at the beginning of the Interrupt Acknowledge transaction.
- Internal circuitry allows for the reset provided by the ZB to be recognized as a reset by the Z-SCC. All timing references assume 20 V for a logic "1" and 08 V for a logic "0".

Table 10. Z80C30 Read/Write Timing¹ (continued)

No	Symbol	Parameter	8 MHz		10 MHz	
			Min	Max	Min	Max
22	TdAS(DR)	$\overline{AS}$ Rise to Read Data Valid Delay		250		190
23	TdDS(DRz)	$\overline{DS}$ Rise to Read Data Float Delay ⁴		40		35
24	TdA(DR)	Address Required Valid to Read Data Valid Delay		260		210
25	TdDS(W)	$\overline{DS}$ Fall to Wait Valid Delay ⁵		170		160
26	TdDSf(REQ)	$\overline{DS}$ Fall to $\overline{W/REQ}$ Not Valid Delay		170		160
27	TdDSr(REQ)	$\overline{DS}$ Fall to $\overline{DTR/REQ}$ Not Valid Delay		4TcPC		4TcPC
28	TdAS(INT)	$\overline{AS}$ Rise to $\overline{INT}$ Valid Delay ⁵		500		500
29	TdAS(DSA)	$\overline{AS}$ Rise to $\overline{DS}$ Fall (Acknowledge) Delay ⁶	250		225	
30	TwDSA	$\overline{DS}$ (Acknowledge) Low Width	150		125	
31	TdDSA(DR)	$\overline{DS}$ Fall (Acknowledge) to Read Data Valid Delay		140		120
32	TsiEI(DSA)	IEI to $\overline{DS}$ Fall (Acknowledge) Setup Time	80		80	
33	ThIEI(DSA)	IEI to $\overline{DS}$ Rise (Acknowledge) Hold Time	0		0	
34	TdIEI(IEO)	IEI to IEO Delay		90		90
35	TdAS(IEO)	$\overline{AS}$ Rise to IEO Delay ⁸		200		175
36	TdDSA(INT)	$\overline{DS}$ Fall (Acknowledge) to $\overline{INT}$ Inactive Delay ⁵		450		450
37	TdDS(ASQ)	$\overline{DS}$ Rise to $\overline{AS}$ Fall Delay for No Reset	15		15	
38	TdASQ(DS)	$\overline{AS}$ Rise to $\overline{DS}$ Fall Delay for No Reset	20		15	
39	TwRES	$\overline{AS}$ and $\overline{DS}$ Coincident Low for Reset ^h	150		100	

Notes:

1. Units in nanoseconds (ns) unless otherwise noted.
2. Parameter does not apply to Interrupt Acknowledge transactions.
3. Parameter applies only between transactions involving the SCC.
4. Float delay is defined as the time required for a ± 0.5 V change in the output with a maximum DC load and a minimum AC load.
5. Open-drain output, measured with open-drain test load.
6. Parameter is system dependent. For any Z-SCC in the daisy chain. TdAS(DSA) must be greater than the sum of TdAS(IEO) for the highest priority device in the daisy chain TsiEI(DSA) for the Z-SCC, and TdIEIf(IEO) for each device separating them in the daisy chain.
7. Parameter applies only to a Z-SCC pulling INT Low at the beginning of the Interrupt Acknowledge transaction.
8. Internal circuitry allows for the reset provided by the ZB to be recognized as a reset by the Z-SCC. All timing references assume 20 V for a logic "1" and 08 V for a logic "0".

Table 10. Z80C30 Read/Write Timing¹ (continued)

No	Symbol	Parameter	8 MHz		10 MHz	
			Min	Max	Min	Max
40	TwPCI	PCLK Low Width	50	1000	40	1000
41	TwPCh	PCLK High Width	50	1000	40	1000
42	TcPC	PCLK Cycle Time	125	2000	100	2000
43	TrPC	PCLK Rise Time		10		10
44	TfPC	PCLK Fall Time		10		10

Notes:

1. Units in nanoseconds (ns) unless otherwise noted.
2. Parameter does not apply to Interrupt Acknowledge transactions.
3. Parameter applies only between transactions involving the SCC.
4. Float delay is defined as the time required for a ± 0.5 V change in the output with a maximum DC load and a minimum AC load.
5. Open-drain output, measured with open-drain test load.
6. Parameter is system dependent. For any Z-SCC in the daisy chain, TdAS(DSA) must be greater than the sum of TdAS(IEO) for the highest priority device in the daisy chain TsiEI(DSA) for the Z-SCC, and TdIEIf(IEO) for each device separating them in the daisy chain.
7. Parameter applies only to a Z-SCC pulling INT Low at the beginning of the Interrupt Acknowledge transaction.
8. Internal circuitry allows for the reset provided by the ZB to be recognized as a reset by the Z-SCC. All timing references assume 20 V for a logic "1" and 08 V for a logic "0".

Figure 38 shows a general timing diagram for the Z80C30 device, and Z80C30 General Timing1 lists its associated general timing characteristics.

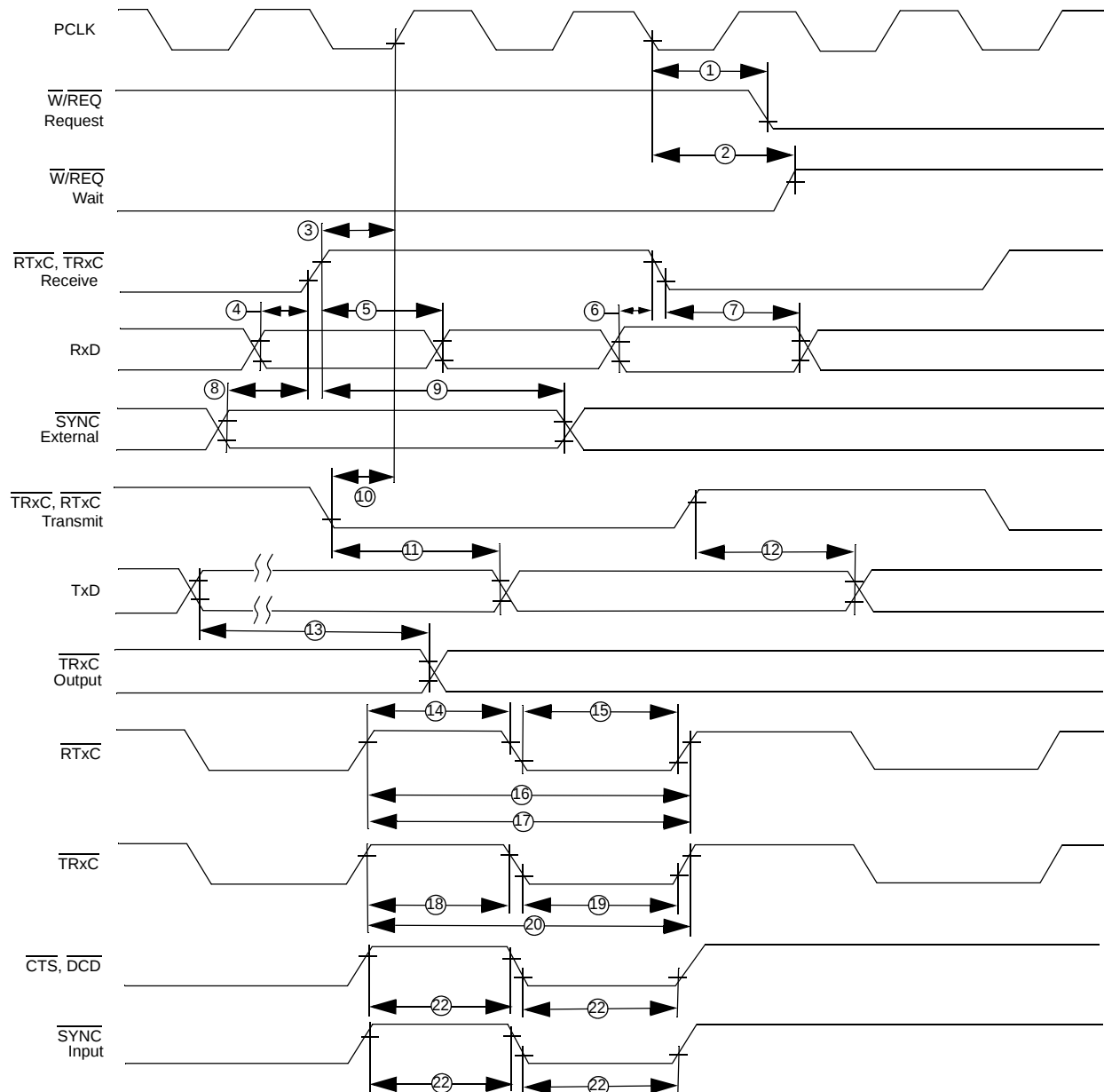


Figure 38. Z80C30 General Timing Diagram

Table 11. Z80C30 General Timing¹

No	Symbol	Parameter	8MHz		10MHz	
			Min	Max	Min	Max
1	TdPC(REQ)	PCLK Low to W/REQ Valid		250		200
2	TsPC(W)	PCLK Low to Wait Inactive		350		300
3	TsRXC(PC)	RxC High to PCLK High Setup Time ^{2,3}	NA	NA	NA	NA
4	TsRXD(RxCr)	RxD to RxC High Setup Time	0		0	
5	ThRXD(RxCr)	RxD to RxC High Hold Time ²	150		125	
6	TsRXD(RxCf)	RxD to RxC Low Setup Time ^{2,4}	0		0	
7	ThRXD(RxCf)	RxD to RxC Low Hold Time ^{2,4}	150		125	
8	TsSY(RXC)	SYNC to RxC High Setup Time ²	-200		-150	
9	ThSY(RXC)	SYNC to RxC High Hold Time ²	5TcPc		5TcPc	
10	TsTXC(PC)	TxC Low to PCLK High Setup Time ^{3,5}	NA		NA	
11	TdTXCf(TXD)	TxC Low to TxD Delay ⁵		190		150
12	TdTxCr(TXD)	TxC High to TxD Delay ^{4,5}		190		150
13	TdTXD(TRX)	TxD to TRxC Delay		200		140
14	TwRTXh	RTxC High Width ⁶	130		120	
15	TwRTXI	TRxC Low Width ⁶	130		120	
16a	TcRTX	RTxC Cycle Time ^{6,7}	472		400	
16b	TxRx (DPLL)	DPLL Cycle Time Min ^{7,8}	59		50	
17	TcRTXX	Crystal Osc. Period ⁹	118	1000	100	1000
18	TwTRXh	TRxC High Width ⁶	130		120	
19	TwTRXI	TRxC Low Width ⁶	130		120	
20	TcTRX	TRxC Cycle Time ^{6,7}	472		400	
21	TwEXT	DCD or CTS Pulse Width	200		120	
22	TwSY	SYNC Pulse Width	200		120	

Notes:

1. Units in nanoseconds (ns) otherwise noted.
2. RxC is RTxC or (TRxC, whichever is supplying the receive clock.
3. Synchronization of RxC to PCLK is eliminated in divide by four operation.
4. Parameter applies only to FM encoding/decoding.
5. TxC is TRxC or RTxC, whichever is supplying the transmit clock.
6. Parameter applies only for transmitter and receiver; DPLL and Baud Rate Generator timing requirements are identical to case PCLK requirements.
7. The maximum receive or transmit data rate is 1/4 PCLK.
8. Applies to DPLL clock source only Maximum data rate of 1/4 PCLK still applies DPLL clock should have a 50% duty cycle.
9. Both RTxC and SYNC have 30 pf capacitors to ground connected to them.

Figure 39 shows a system timing diagram for the Z80C30 device, and Z80C30 System Timing lists its associated parameters.

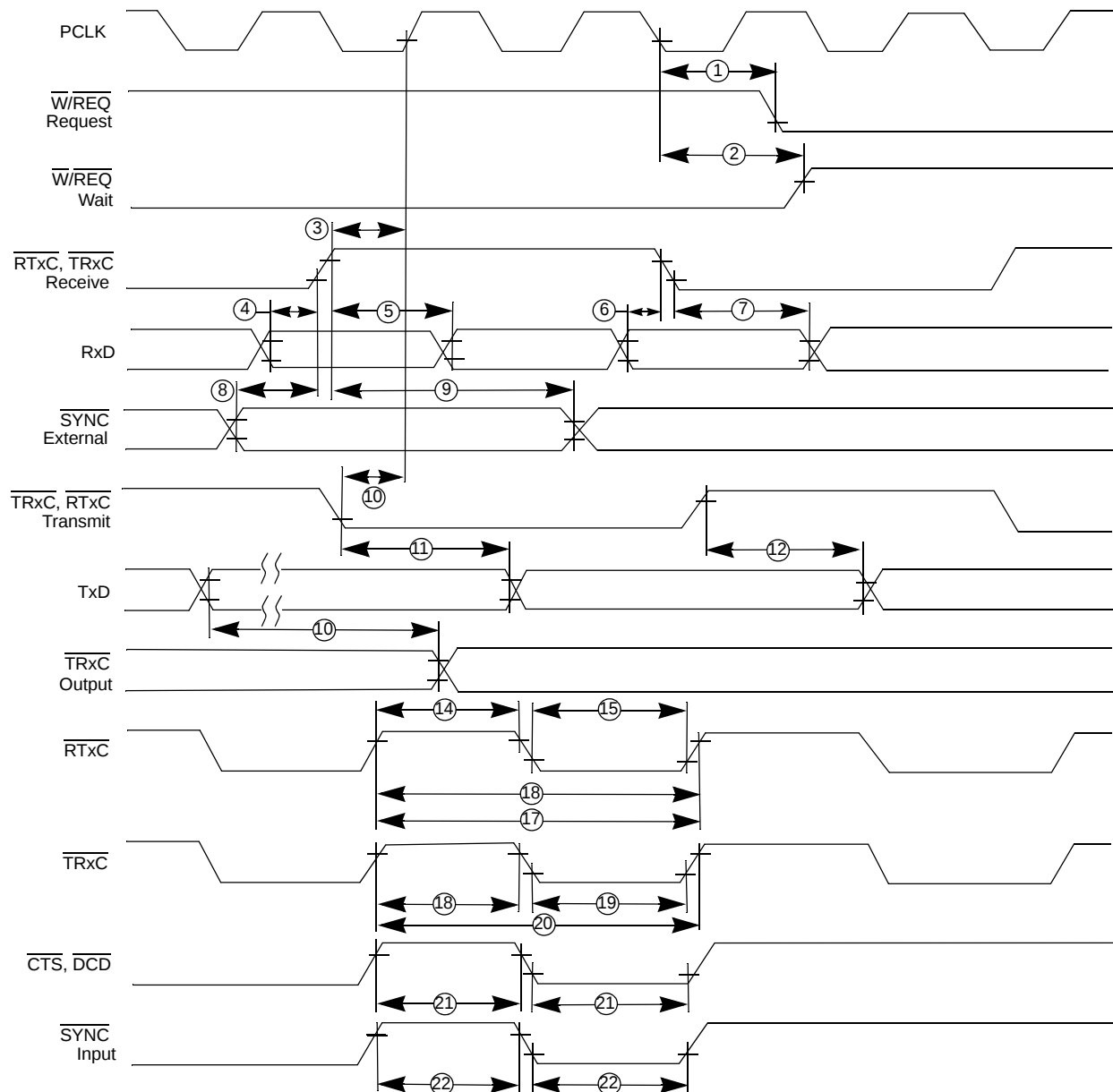


Figure 39. Z80C30 System Timing Diagram

Table 12. Z80C30 System Timing

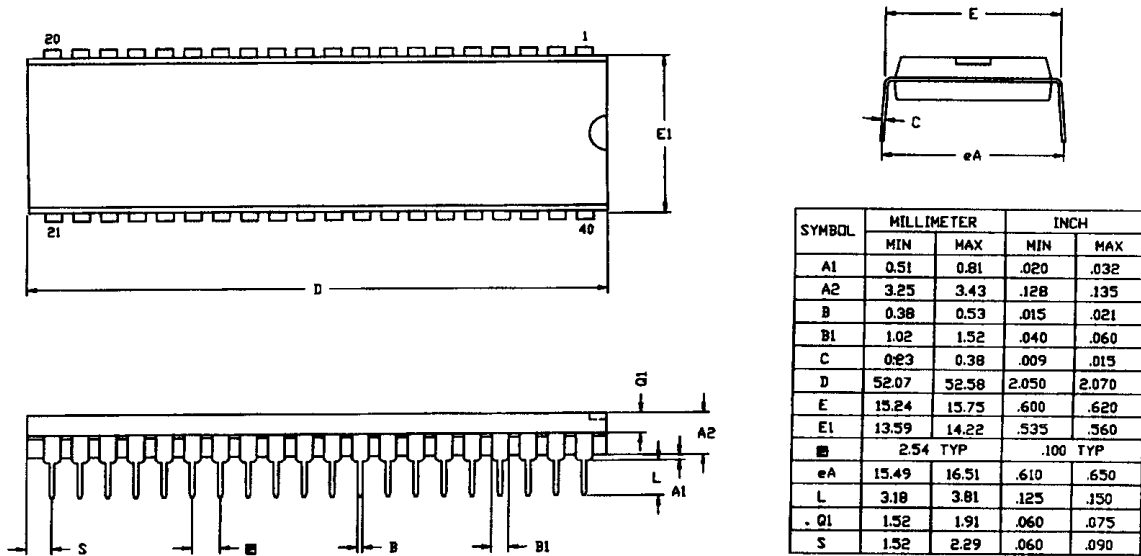
No	Symbol	Parameter	8MHz		10MHz	
			Min	Max	Min	Max
1	TdRXC(REQ)	RxC High to $\overline{W}/\overline{REQ}$ Valid ^{1,2}	8	12	8	12
2	TdRXC(W)	RxC High to Wait Inactive ^{1,2,3}	8	14	8	14
3	TdRdXC(SY)	RxC High to SYNC Valid ^{1,2}	4	7	4	7
4	TdRXC(INT)	RxC High to INT Valid ^{1,2,3}	8	12	8	12
			2 ⁴	3 ⁴	2 ⁴	3 ⁴
5	TdTXC(REQ)	TxC Low to $\overline{W}/\overline{REQ}$ Valid ^{e,2}	5	8	5	8
6	TdTXC(W)	TxC Low to Wait Inactive ^{1,2,3}	5	11	5	11
7	TdTXC(DRQ)	TxC Low to $\overline{DTR}/\overline{REQ}$ Valid ^{2,3}	4	7	4	7
8	TdTXC(INT)	TxC Low to $\overline{INT}$ Valid ^{1,2}	4	6	4	6
			2 ⁴	3 ⁴	2 ⁴	3 ⁴
9a	TdSY(INT)	SYNC to INT Valid ^{2,3}	2	6	2	6
9b	TdSY(INT)	SYNC to INT Valid ^{2,3,4}	2	3	2	3
10	TdEXT(INT)	Note ^{2,3,4}	2	3	2	3

Notes:

1. RxC is $\overline{RTxC}$ or $\overline{TRxC}$ whichever is supplying the receive clock.
2. Units equal to TcPc.
3. Open-drain output, measured with open-drain test load.
4. Units equal to AS.
5. TxC is $\overline{TRxC}$ or $\overline{RTxC}$, whichever is supplying the transmit clock.

Packaging

Figure 40 shows the 40-pin DIP package available for the Z80C30 and Z85C30 devices.



CONTROLLING DIMENSIONS : INCH

Figure 40. 40-Pin DIP Package Diagram

Figure 41 shows the 44-pin Plastic Leaded Chip Carriers (PLCC) package diagram available for Z80C30 and Z85C30 devices.

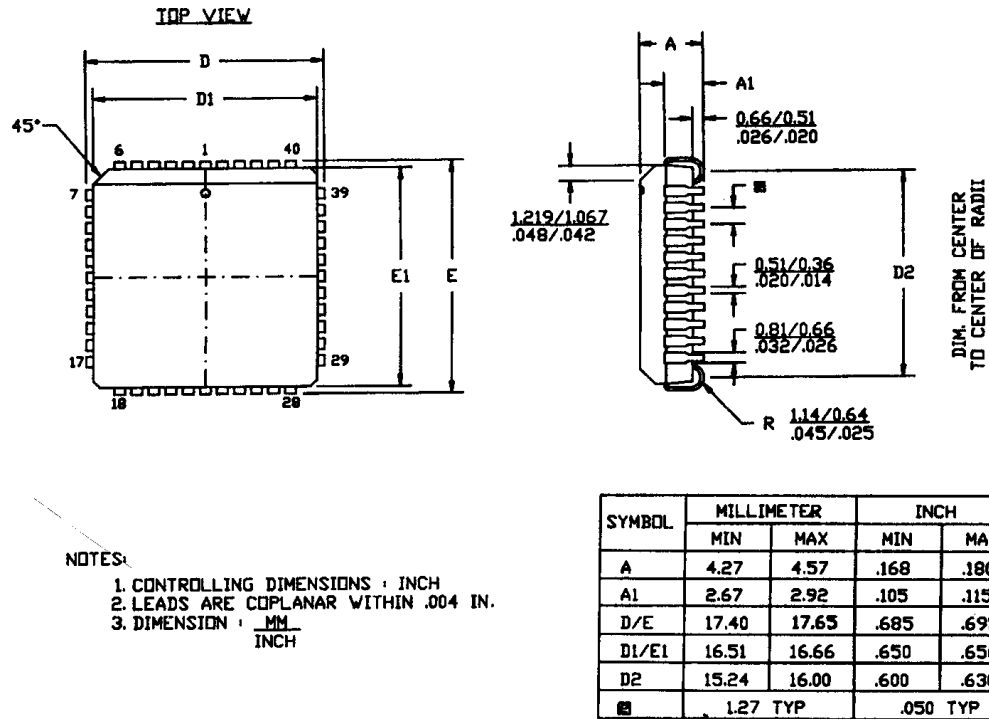


Figure 41. 44-Pin PLCC Package Diagram

Ordering Information

Z80C30/Z85C30 Ordering Information provides ordering information for the Z80C30 and the Z85C30 devices.

Table 13. Z80C30/Z85C30 Ordering Information

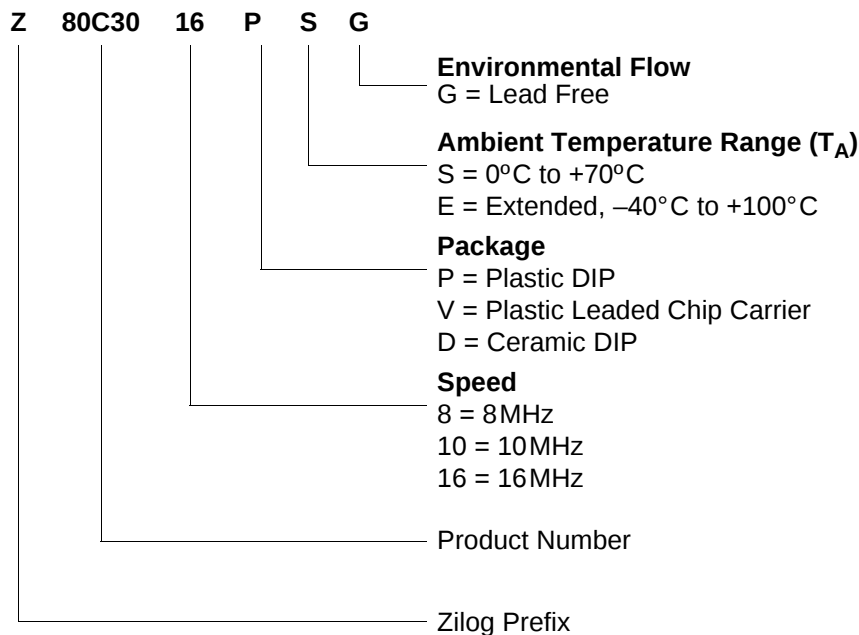
8 MHz	10 MHz	16 MHz
Z80C3008VSG	Z80C3010VSG	Z85C3016PSG
Z85C3008PSG/PEG	Z85C3010PSG/PEG	Z85C3016VSG
Z85C3008VSG/VEG	Z85C3010VSG/VEG	

For complete details about Zilog's Z80C30 and Z85C30 devices, development tools and downloadable software, visit www.zilog.com.

Part Number Suffix Designations

Zilog part numbers consist of a number of components, as indicated in the following example:

Part number Z80C3016PSG is a Z80C30, 16MHz, PLCC, 0°C to +70°C, Lead Free



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